

NBSIR 75-975

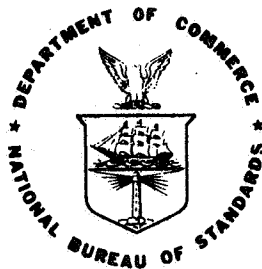
The Calibration of an Optical Flat by Interferometric Comparison to a Master Optical Flat

Charles P. Reeve

Institute for Basic Standards
National Bureau of Standards
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The Calibration of an Optical Flat

by Interferometric Comparison to a Master Optical Flat

by

Charles P. Reeve

1. Introduction

The Dimensional Technology Section has been involved in the calibration of optical flats for many years. Present facilities are capable of handling any flat whose diameter does not exceed 16 inches. All test flats are calibrated by either the "2-flat method" or the "3-flat method". The former method is a direct comparison of the test flat to an NBS master flat whose surface profile is well known. The latter method involves an intercomparison between three flats, none of whose profiles need be known. Most test flats are calibrated by the 2-flat method because it is simpler and requires fewer measurements. The 3-flat method is used only for the calibration of NBS master flats or for special calibrations.

The purpose of this report is to present a fairly detailed description of the procedures used in calibrating an optical flat by the 2-flat method. Emphasis is on the geometrical aspects of the setup, the method of obtaining data, the mathematics of data reduction, and the display of the computed results. Some useful results from previous 3-flat calibrations are also incorporated.

2. Preliminaries

2.1. Physical Properties

Normally an optical flat is used in the laboratory as a reference plane in connection with some measurement process. The flat is disc-shaped with parallel or nearly parallel surfaces, one or both of which are of finished optical quality (within a few microinches of flatness except for dubbing at the edges). The most common material for an optical flat is fused quartz, but many are made of glass or one of the newer materials which has a very small coefficient of thermal expansion.

The surface of a fused quartz flat reflects only about 3% of the incident light, so the surface is often coated to give a higher reflec-

tivity. Depending on the type and thickness of the coating, reflectivity can be increased to nearly 100%. A flat with such a highly reflective coating is usually referred to as a mirror. In defining the point where a flat becomes a mirror, use is made of the fact that the closer the reflectivity of two interfering surfaces, the more distinct the fringes. Thus any coated flat which is too reflective to give usable fringes, in the judgement of the observer, against an uncoated master flat is considered to be a mirror and must be calibrated against a coated master flat.

Most flats have two perpendicular diameters which are identified as A-B and C-D by markings on the side. On a one-sided flat the finished surface is indicated and on a two-sided flat the surfaces are usually identified as 1 and 2 or T and B.

2.2. "One-dimensional" Flatness

The objective of the 2-flat method is to measure the profile of the test flat along the specified diameters. This is accomplished by individually comparing each test flat diameter to the known diameter of the appropriate master flat. The measurement process yields an estimated profile for each diameter of the test flat in the form of a discrete number of points $(x_1, y_1), \dots, (x_n, y_n)$ where x_i denotes a position along the diameter and y_i denotes the measured deviation of the surface from some reference line at the position x_i . A sample set of points is given in figure 2.1 where $n=7$. The set of n points corresponding to a given diameter may be plotted and connected by a smooth curve to give a perspective of the measured profile along that diameter as shown in figure 2.2.

Although the surface of an optical flat is often used as a two-dimensional reference plane, it is not calibrated in the two-dimensional sense by the method described herein. This method is most accurately described as a "one-dimensional" flatness measurement with the y_i values being reported as "deviations from a straight line".

2.3. Choice of Profile Reference Line

The choice of which reference line to use in reporting deviations is arbitrary. A set of deviations relative to one straight line can easily be converted to deviations from another. Several definitions of the reference line have been used at the National Bureau of Standards in recent years. Some of these methods of defining the reference line and reporting deviations are:

MEASURED VALUES OF OPTICAL FLAT PROFILE

i	x_i	y_i
1	.06	+ 0.10
2	1.00	1.81
3	2.00	2.79
4	2.50	3.20
5	3.00	3.05
6	4.00	2.89
7	4.94	2.90

Figure 2.1

PLOT OF PROFILE VALUES CONNECTED BY A SMOOTH CURVE

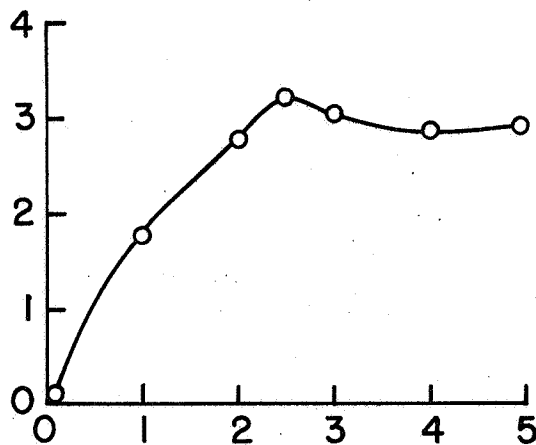


Figure 2.2

(1) If the profile appears to be simply convex or concave let the reference line pass through the end values, and if the deviation of the center value from the line is "d", then report the profile to be "d" microinches convex or "d" microinches concave, depending on the direction of the curvature (fig. 2.3).

(2) Let the reference line pass through the end values and report the deviations from this line (fig. 2.4).

(3) Let the reference line pass through the end values, translate it so that it passes through the center point, and report deviations from this line (fig. 2.5).

(4) Fit a "least squares" line through all values (with the possible exception of the end values) and report deviations from this line (fig. 2.6).

The first method is no longer used because it has the overtones of being a certification rather than a calibration. The last three methods report the measured profile relative to different lines, but they all provide the same information. One cannot say that one reference line is more correct than another. They are all arbitrary and interchangeable. The fourth method, however, is now being used because all measured values have some weight in determining the reference line, and therefore an outlying measurement at some point would have a minimal effect on the deviations from the line at other points.

3. Geometrical Model for 2-Flat Comparison

3.1. Method of Support

When a given diameter of the test flat is compared to the known master diameter one flat is placed horizontally on top of the other so that the two diameters are adjacent and lie in the same vertical plane as shown in figure 3.1. The lower flat is supported on three thin pads which are equidistant from each other. Two of the pads lie on a line parallel to the test diameter. Let the distance from each pad to the center be denoted by $k_L r_L$, where r_L is the radius of the lower flat and k_L is a constant between zero and one. Similarly, the upper flat is supported on the lower flat by three thin pads, each at a distance of $k_U r_U$ from the center of the upper flat. These three pads are also equidistant and have the same orientation as the pads supporting the lower flat. The pad farthest from the diameter (indicated by +) is slightly thicker than the other two so that the air space between the flats is wedge-shaped. The constants k_L and k_U are chosen in a way that will maximize the effectiveness of the measurement system. Guidelines for determining these parameters are discussed later.

"d" MICROINCHES CONVEX

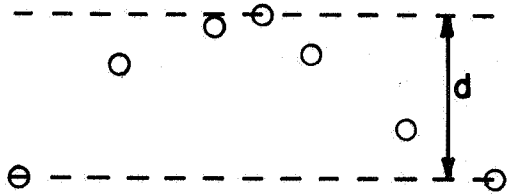


Figure 2.3

$y_1 = y_7 = 0$

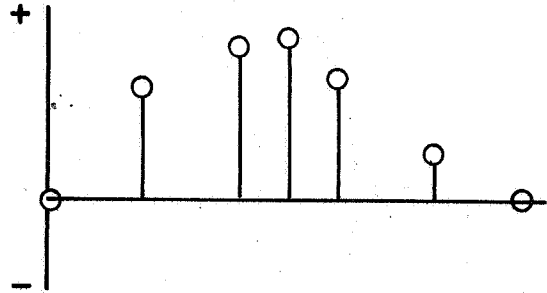


Figure 2.4

$y_4 = 0$ $y_1 = y_7$

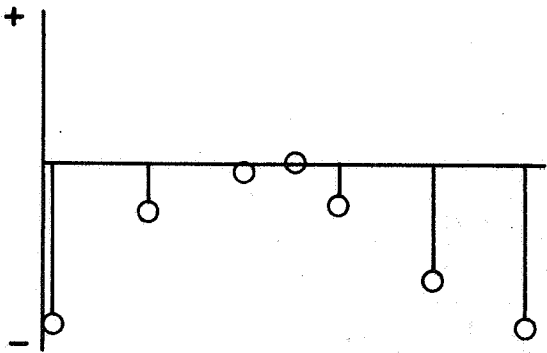


Figure 2.5

Least squares line does not include end points

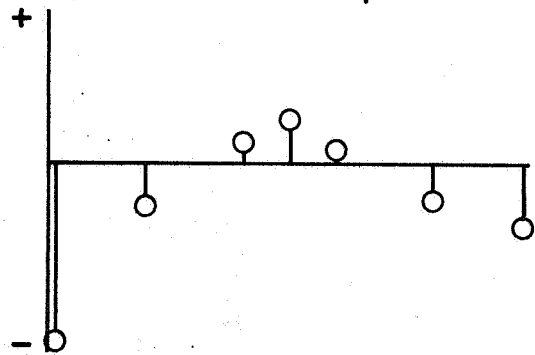


Figure 2.6

2-FLAT SETUP

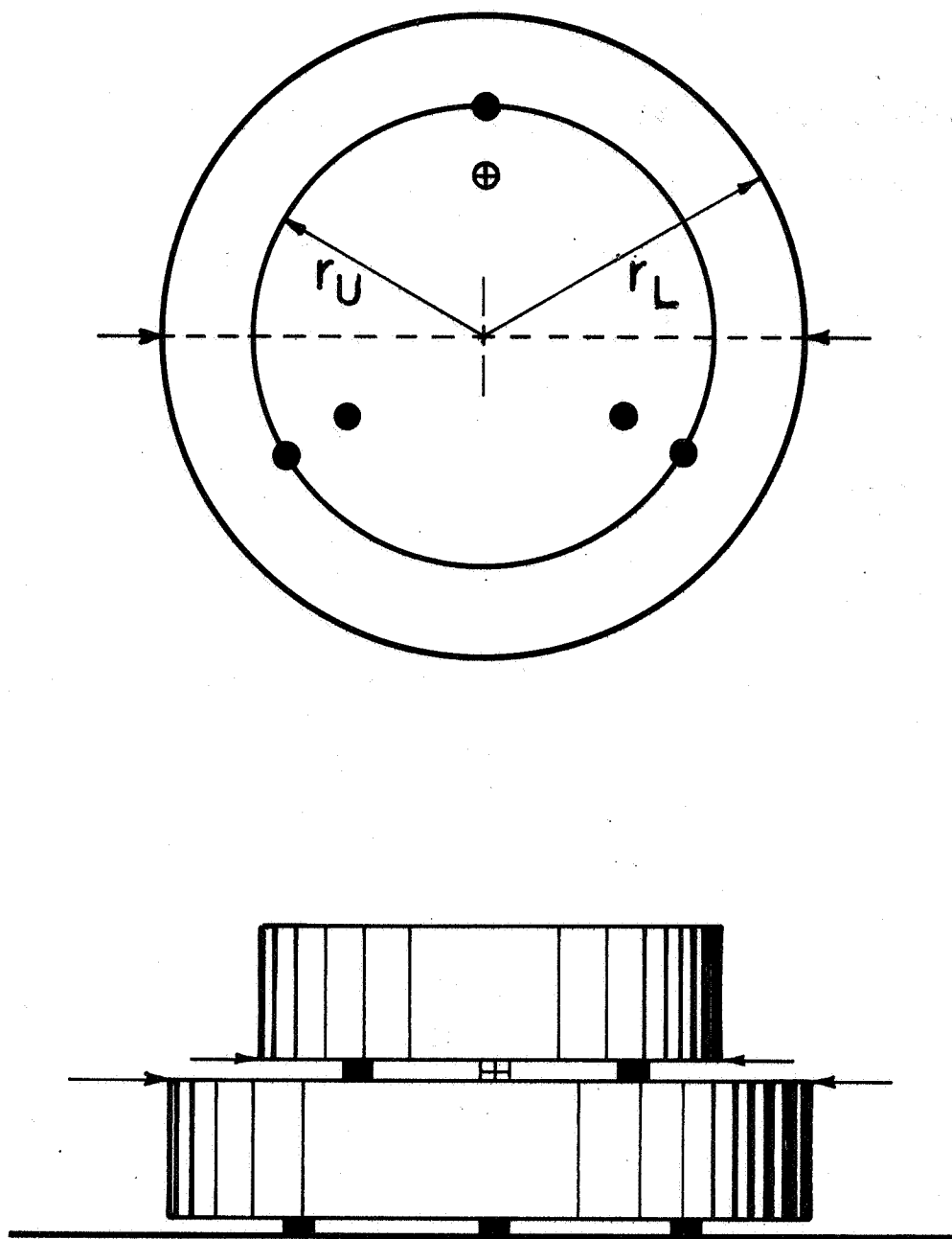


Figure 3.1

3.2. Coordinate System

It is necessary to assign a coordinate system to each diameter of the test flat for the purpose of identifying points along the diameter at which measurements of the surface profile are to be made. Readings are taken at n positions along each diameter where n is usually odd. These positions are denoted by (x_1, \dots, x_n) and are usually symmetrically spaced about the center point at inch or half-inch intervals. If the end positions fall at the extreme edge of the flat they are moved one-sixteenth of an inch toward the center. The positions are usually chosen to coincide with those used in previous calibrations. If the flat has not previously been calibrated the positions are chosen as deemed appropriate. The x_1 position is at the A end of the A-B diameter and the C end of the C-D diameter, and the x_n position is at the B and D ends respectively.

3.3. Gravitational Bending

The freeform profile of an optical flat is defined as that form which the flat would take in a zero-gravity environment. Since no such environment yet exists in earthbound laboratories the distortion of optical flats by gravitational bending must be considered.

When a flat is supported on three pads, the test diameter will have an apparent profile (a) which is the sum of its freeform profile (f) and its bending profile (b). The bending profile is dependent on the support radius of the pads and whether the diameter is on the top or bottom surface of the flat. Many years ago Emerson [4]* showed experimentally that when the support radius of the pads is set so that minimum bending occurs, then the bending is small enough to be neglected. This result is discussed in section 4.2. The current calibration process calls for all test flats and most master flats to be supported at the minimum bending radius. The exception is discussed in section 5.2.

4. Some Results of 3-Flat Comparisons

Although the 3-flat method has not been described in detail, it has been used to give some important results which are relevant to the functioning of the 2-flat method. These results fall into two groups.

4.1. Calibration of NBS Master Flats

The 3-flat method is ideal for calibrating master flats because it

* Figures in brackets indicate literature references listed at the end of this paper.

RING SUPPORT AT EDGE

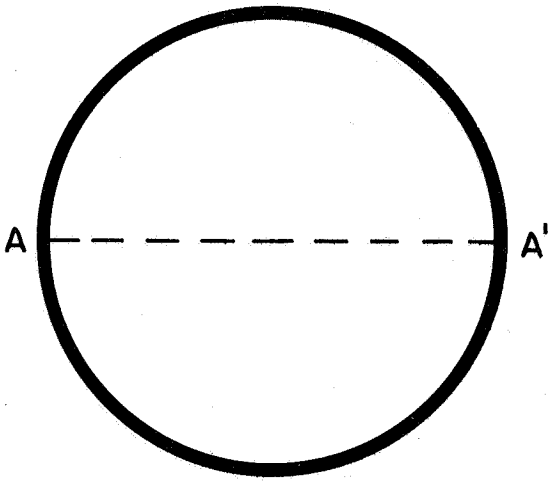


Figure 4.1

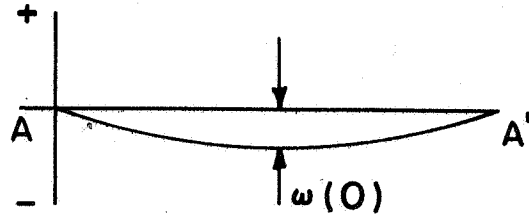


Figure 4.2

THREE POINT SUPPORT AT EDGE

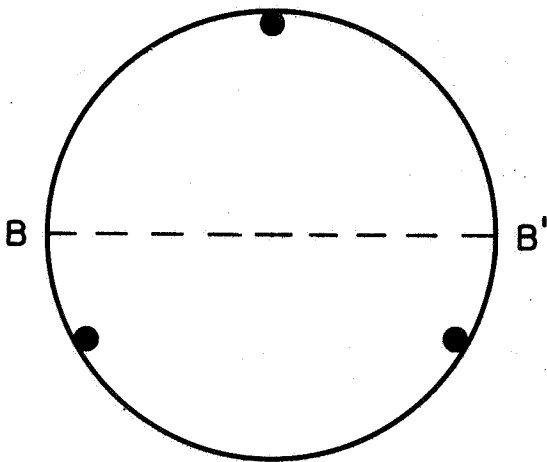


Figure 4.3

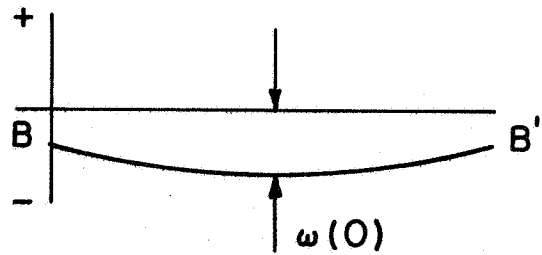


Figure 4.4

gives an "absolute" calibration. No master values are needed and the process is relatively free of systematic errors. The measurement scheme is such that the bending profiles are removed leaving only the freeform profiles. The more commonly used masters are recalibrated by this method occasionally to check on their stability.

4.2. Empirical and Theoretical Bending

In 1950 and 1954 three 10.6 inch master flats (designated #1-1, #1-2, and #1-3) were involved in a thorough study headed by Emerson[4] where the profiles and bending characteristics of the flats were measured. Bending profiles of flat #1-3 were determined for six different support radii. Currently this is the only NBS master flat for which experimentally derived bending corrections exist.

One result of the bending research was the discovery that minimum bending along the test diameter occurs when the support pads are located at $.70r$ from the center. This result is not surprising since the circle of radius

$$r_0 = \frac{r}{\sqrt{2}} = .7071r$$

divides the mass of the flat into equal parts. The bending corrections for the $.70r$ support were found to be negligible for the 10.6 inch flat, so it is usually assumed that when flats of this size or smaller are supported at $.70r$ the bending is negligible and the apparent profile is the same as the freeform profile.

Some theoretical bending values have been developed by Timoshenko[5] for circular flats using the following two types of support:

I. Ring support at the edge

Figures 4.1 and 4.2 show a flat supported at the edge by a narrow ring and the corresponding profile of diameter AA'. On the diameter AA', a distance r from the center, the bending deflection or sag $w(r)$ is given by the formula

$$w(r) = \frac{3\rho g(1-\nu^2)(a^2-r^2)}{16Eh^2} \left[\frac{(5+\nu)}{(1+\nu)} * a^2 - r^2 \right] + \frac{\rho g}{4E} (3+\nu)(a^2 - r^2) \quad (4-1)$$

where: a = radius (in.)
 h = thickness (in.)
 ν = Poisson's ratio (dimensionless)
 ρg = density (lb./in.³)
 E = Young's modulus (lb./in.²).

Note that if the ratio a/h is large, then the first term greatly exceeds the second, so $w(r)$ can then be considered inversely proportional to the square of the thickness.

Example. For NBS master flat #1-3, $a = 5.3$, $h = 2.5$, $\nu = 0.14$, $E = 10.15 \times 10^6$, and $\rho g = .079876$. By letting $r = 0$, the sag at the center relative to the ring support is computed to be

$$w(0) = .823 + .174 = .997 \text{ microinches.}$$

Note that $w(a) = 0$.

II. Three point support at the edge

Figures 4.3 and 4.4 show a flat supported at the edge on three points and the corresponding profile of diameter BB' . The formula for the bending deflection is given only for $r = 0$ as

$$w(0) = .0362 \frac{Pa^2}{D} \quad (4-2)$$

where $P = \pi a^2 q$, $D = Eh^3/12(1-\nu^2)$, and $q = \rho gh$. Combining terms then

$$w(0) = \frac{1.3647 \rho g (1-\nu^2) a^4}{Eh^2} \quad (4-3)$$

Example. For NBS master flat #1-3, using the same values as before,

$$w(0) = 1.329 \text{ microinches.}$$

The value $w(a)$ for the second example is obviously not equal to zero but since the formula given is only for $r = 0$ it is unclear how to determine the deflection for values of r different from zero. Consequently, it is impossible to directly compare this theoretical bending value with the observed bending value obtained by Emerson.

These two theoretical formulae, though interesting, have little or no application to the current measuring process. Only by making certain gross assumptions could they be applied and at the present time it is felt that such assumptions cannot be justified.

The conclusion of this section then is that when an optical flat is being used as a master it should be supported at $.70r$ where bending is assumed to be negligible. It should be supported at another radius only when experimentally obtained bending values have been established. In

that case the apparent profile of the master is computed by adding or subtracting (whichever is appropriate) the bending profile to (or from) the freeform profile.

5. Measurement Process

5.1. Calibration Facilities

The current optical flat calibration facilities are located in a laboratory which is maintained at a constant temperature of 20° Celsius and at a near constant humidity. In order to keep the temperature stable during the measurement process, only the person who is making the measurements is allowed in the room. It is certain that thermal gradients do exist within the optical flats, but it is assumed that they are small enough in magnitude to be neglected; therefore, no attempt is made to correct for temperature. It is also known that the daily variation in atmospheric pressure affects the wavelength of light, but this effect is negligible because only small differences in profile are measured.

The master and test flat assembly is encased in a cardboard and aluminum foil insulating shell and is set on ways which allow it to pass back and forth under a Pulfrich viewer as shown in figures 5.1 and 5.2. The maximum travel on the ways is slightly more than 16 inches.

5.2. Choice of Master Flat and Support Radii

In determining the best setup to use for calibrating a given test flat, the following facts must be considered:

- (1) The test flat must be supported at seven-tenths of its own radius.
- (2) The master flat must be supported at seven-tenths of its own radius unless its bending corrections are known.
- (3) Due to bending considerations it is best to have the heavier flat on the bottom.
- (4) If the weight of the upper flat will significantly bend the lower flat then the support pads for the upper flat must be directly above the support pads for the lower flat.
- (5) NBS master flat #1-3 may be supported anywhere from $.25r_M$ to $1.00r_M$ if bending corrections are properly applied.

The guidelines in table A have evolved from these considerations.

TOP VIEW OF CALIBRATION SETUP

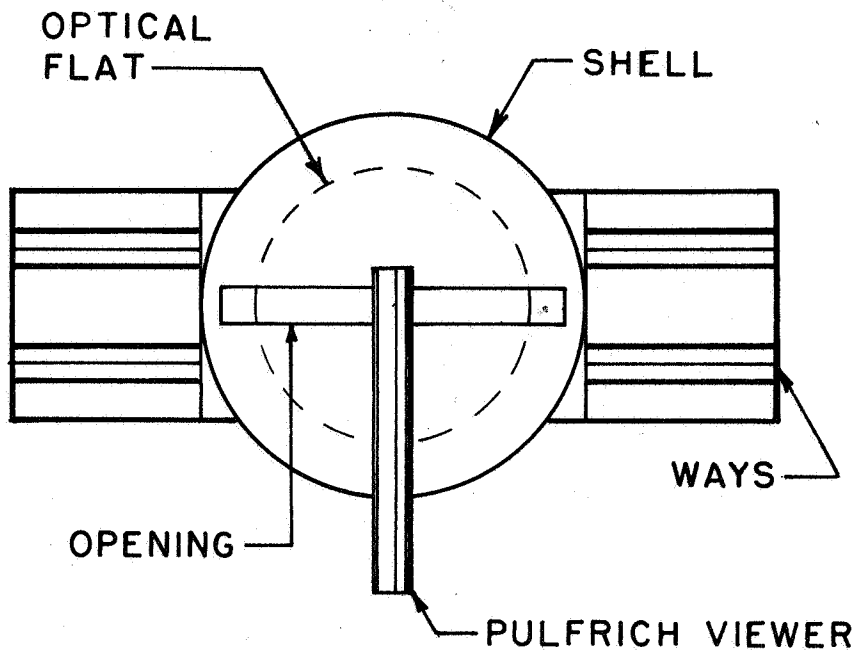


Figure 5.1

DIAGRAM OF INTERFEROMETER

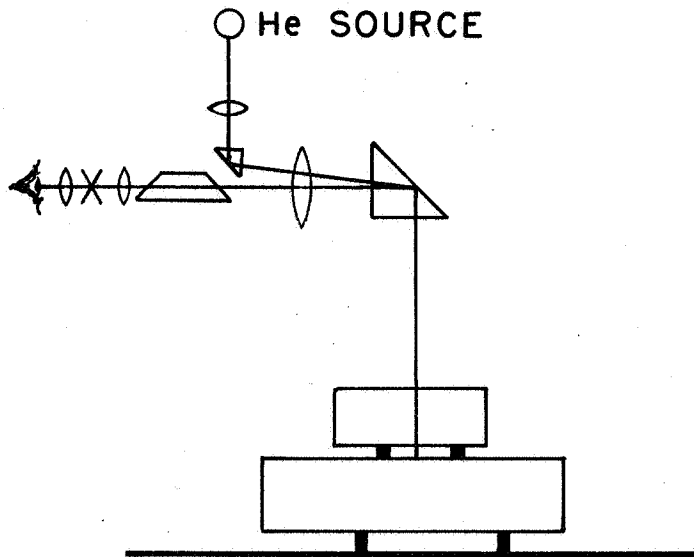


Figure 5.2

5.3. Preparation for Measurement

When two flats are set up for measurement, the alignment of the assembly should be checked to be sure that the test diameter passes back and forth directly under the viewer. When the lamp is turned on a series of interference fringes will be observed running roughly parallel to the diameter. It is desirable that these fringes be as nearly parallel to the diameter as possible. A slight angular movement of the fringes can be obtained by pressing lightly over one of the thin pads. It is then very important to check the direction of the wedge by pressing lightly over the thicker pad. This should make the fringe separation wider. If the fringe separation becomes narrower it indicates that the "thick" pad is actually thinner than the thin pads, and the resulting sign reversal will create errors in the computed values of the profile. This method of increasing the fringe separation also spreads out the dark fringes and makes them fuzzier. By controlling the thickness of the pads the dark area of the fringe can be made just the right width to fit between the crosshairs of the viewer. For helium yellow light and the Pulfrich viewer the ideal distance between fringes is 200-300 micrometer units or 2.2-3.3 millimeters.

The points along the diameter at which measurements are to be made are located with the aid of a paper ruler which has notches cut at the proper x positions. The ruler is laid on top of the upper flat along side the test diameter so that it appears with the fringes in the viewer as shown in figure 5.3.

After all preparations have been completed the flats are allowed to sit for several hours, or preferably overnight, so that they come to thermal equilibrium. It is likely that during this time there will be a slight angular and lateral movement of the fringes. This is allowable because the effect of these changes is removed by the data reduction process.

5.4. Procedure for Taking Data

The fringe which most nearly coincides with the test diameter is chosen as the primary fringe (fig. 5.4). The y position of this fringe is measured at designated points along the diameter. Beginning at the position x_1 the crosshairs are moved by a micrometer dial until they are centered over the primary fringe (fig. 5.3). The dial reading y_1 is recorded. The assembly is then moved by the hand crank until the position x_2 is centered under the viewer and the crosshairs are again centered over the fringe. The reading y_2 is recorded. This process is repeated until readings at all n positions have been made. Then, without delay, the measurements are repeated in reverse order so that a series of $2n$ measurements of the

INTERFERENCE FRINGES

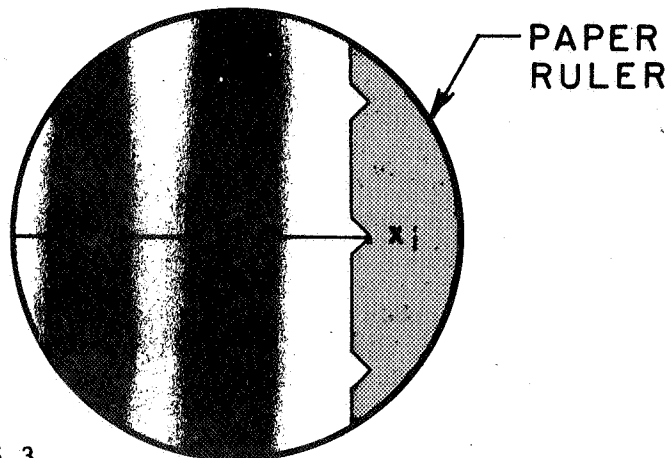


Figure 5.3

PRIMARY FRINGE



Figure 5.4

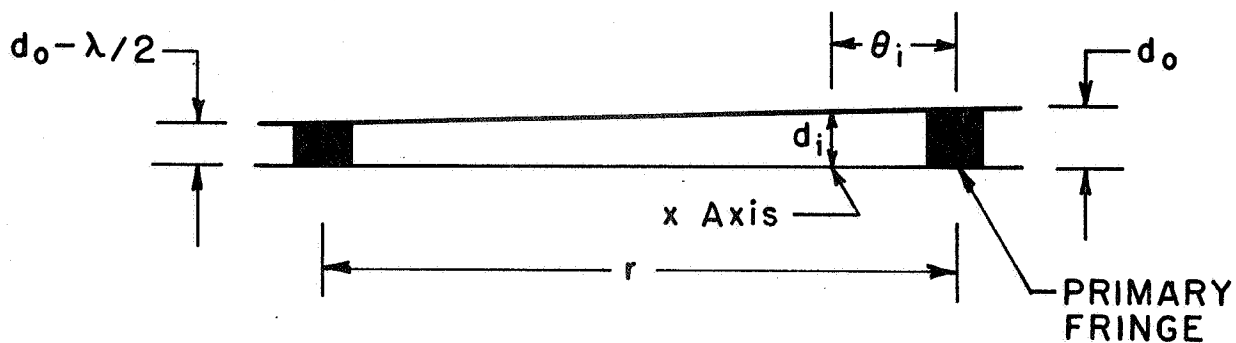


Figure 5.5

fringe profile is generated. Depending on the value of n , the measurements may take up to 30 minutes to complete. These measurements can then be said to constitute one cycle of data. The usual procedure is to take one to four cycles of data at a time which constitutes a run. Directly before and after each run several measurements of the distance between the primary fringe and one of the two adjacent fringes are made. This distance is called the fringe separation and is denoted by " r ". Two independent runs are made per diameter. It is desirable for these runs to be at least two hours apart in order to test the stability of the fringe pattern.

5.5. Mathematical Model of Fringe Profile

In setting up a mathematical model for a run it is necessary to consider that the fringes may drift significantly during the course of the run and the observer may need to take a break of variable length between cycles. The model which follows accounts for these factors. Within each cycle the measurements should be equally spaced in time and completed as quickly as possible. Over this period the fringe drift is assumed to be linear. Between cycles the observer may take a break because nothing is assumed about the behavior of the fringes over that period of time. The entire run, however, should be completed within a couple of hours if possible in order to reduce the number of long-term variations which might arise.

Assume that within a cycle the measurements are spaced by two units of time, and for the sake of symmetry let the time $t=0$ fall halfway between the consecutive measurements at the x_n position. At $t=0$ during the first cycle let the distance from the position x_i on the test diameter to the fringe be given by θ_i as shown in figure 5.6. (The fringes are shown as straight lines for simplicity.) The purpose of the model then is to estimate these values θ_i where $i=1,n$. At times before and after $t=0$ the fringe position will drift, as shown by the dotted lines, and the distance to the fringe will change. This change can be modeled by assuming that at each end point the fringe has a constant drift throughout the cycle. Let b_j denote the rate of movement of the fringe in micrometer units per unit time at the x_i position during the j^{th} cycle, and let d_j similarly denote the rate of movement of the fringe at the x_n position. The movement of the fringe at the x_i position is then a weighted average of the end effects with the weighting function depending on x_i .

Irregular jumps in the fringe position between cycles can easily be modeled. Let a_j be the distance the fringe moves at the x_i position be-

*FRINGE DRIFT DURING CYCLE 1 AND
FRINGE JUMP BETWEEN CYCLES 1 & 2*

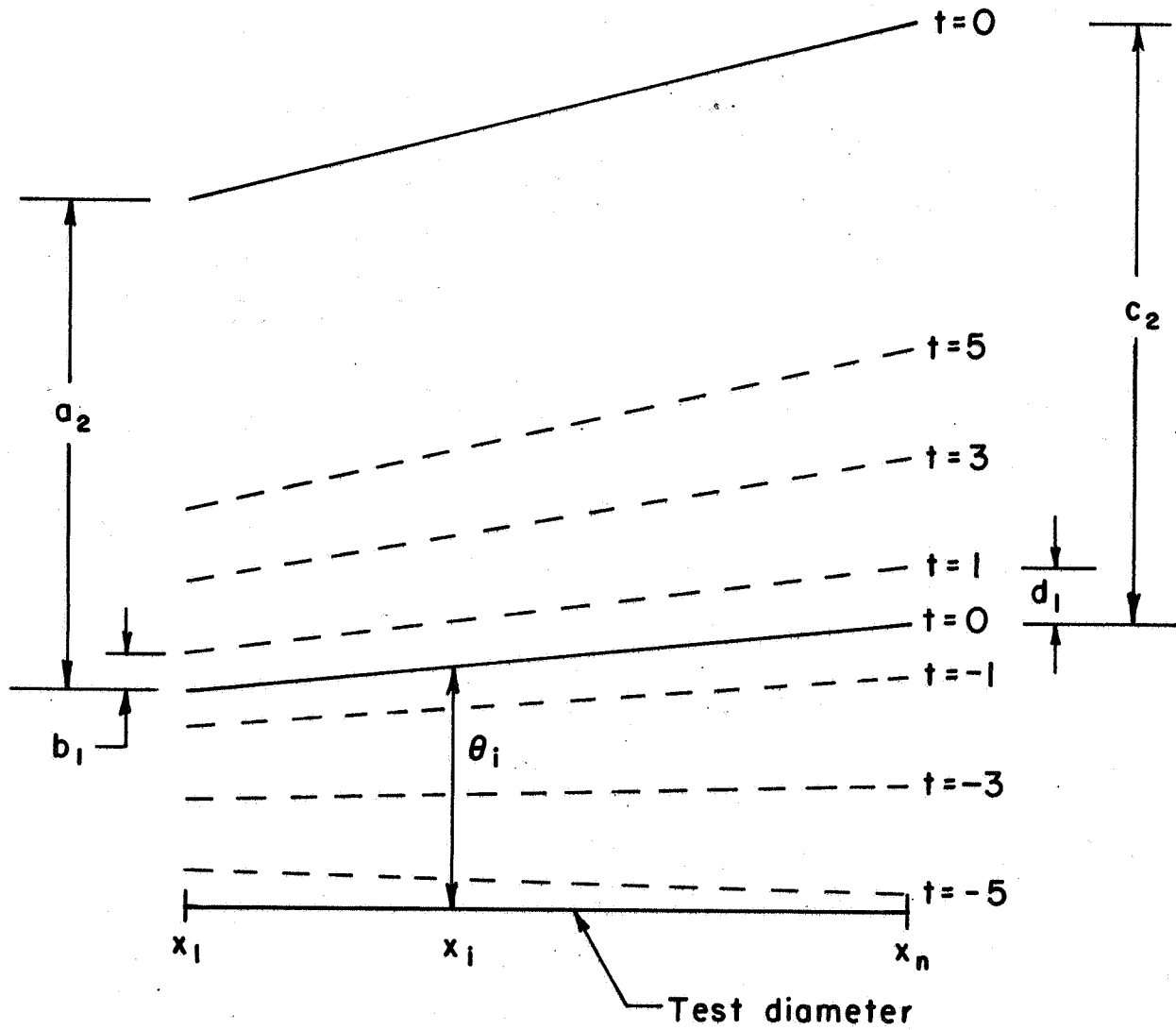


Figure 5.6

tween $t=0$ for the first cycle and $t=0$ for the j^{th} cycle as shown in figure 5.6. Let c_j similarly denote the distance the fringe has moved at the x_n position, and note that $a_1=c_1=0$. Again the movement of the fringe at the x_i position is a weighted average of the end effects. Let m be the number of cycles per run and let y_{ij} be the i^{th} observation in the j^{th} cycle. Then the measurement equations take the form

$$y_{ij} = \theta_i + [a_j + b_j(2i-2n-1)] \left[\frac{x_n - x_i}{x_n - x_1} \right] + [c_j + d_j(2i-2n-1)] \left[\frac{x_i - x_1}{x_n - x_1} \right] + \epsilon_{ij} \quad \text{if } 1 \leq i \leq n, \text{ and} \quad (5-1)$$

$$y_{ij} = \theta_{2n-i+1} + [a_j + b_j(2i-2n-1)] \left[\frac{x_n - x_{2n-i+1}}{x_n - x_1} \right] + [c_j + d_j(2i-2n-1)] \left[\frac{x_{2n-i+1} - x_1}{x_n - x_1} \right] + \epsilon_{ij} \quad \text{if } n < i \leq 2n,$$

where $j=1, m$ and the ϵ_{ij} are independent error values from a distribution with mean zero and variance σ^2 .

This linear model can be solved by the usual method of least squares (i.e., minimizing $\sum_{i=1}^{2n} \sum_{j=1}^m \epsilon_{ij}^2$). Let the $2nm$ observations be given by the vector

$$y = (y_{11} \ y_{21} \ \dots \ y_{2n,1} \ \dots \ y_{1m} \ y_{2m} \ \dots \ y_{2n,m})', \quad (5-2)$$

and let the $n+4m-2$ unknowns be given by the vector

$$\begin{pmatrix} \theta \\ \Omega \end{pmatrix} = (\theta_1 \ \theta_2 \ \dots \ \theta_n \ b_1 \ d_1 \ a_2 \ b_2 \ c_2 \ d_2 \ \dots \ a_m \ b_m \ c_m \ d_m)', \quad (5-3)$$

where θ is $n \times 1$ and Ω is $(4m-2) \times 1$. Since $a_1=c_1=0$, they are not included

in the model. Let p , q , u , and v be vectors of order n whose components are given by

$$\begin{aligned}
 p_i &= \frac{x_n - x_i}{x_n - x_1}, \\
 q_i &= 1 - p_i, \\
 u_i &= (2n - 2i + 1)p_i, \text{ and} \\
 v_i &= (2n - 2i + 1)q_i
 \end{aligned}
 \tag{5-4}$$

where $i=1, n$. Let I be the identity matrix of order n and let K be the $n \times n$ matrix with 1's on the minor diagonal and 0's elsewhere, i.e.,

$$K = \begin{bmatrix} 0 & 0 & \dots & 0 & 1 \\ 0 & 0 & & 1 & 0 \\ \vdots & & \ddots & & \\ 0 & 1 & & 0 & 0 \\ 1 & 0 & & 0 & 0 \end{bmatrix}.
 \tag{5-5}$$

(Note that premultiplication of an $n \times 1$ vector by K flips the vector.) Let the $2nm$ residuals be given by the vector

$$\epsilon = (\epsilon_{11} \ \epsilon_{21} \ \dots \ \epsilon_{2n,1} \ \dots \ \epsilon_{1m} \ \epsilon_{2m} \ \dots \ \epsilon_{2n,m})',
 \tag{5-6}$$

and let the $(2nm) \times (n+4m-2)$ matrix of coefficients be given by

$$X = \begin{bmatrix} I & -u & -v & 0 & 0 & 0 & 0 & 0 & 0 & 0 & 0 \\ K & Ku & Kv & 0 & 0 & 0 & 0 & 0 & 0 & 0 & 0 \\ I & 0 & 0 & p & -u & q & -v & 0 & 0 & 0 & 0 \\ K & 0 & 0 & Kp & Ku & Kq & Kv & 0 & 0 & 0 & 0 \\ \vdots & & & & & & & & & & \\ I & 0 & 0 & 0 & 0 & 0 & 0 & p & -u & q & -v \\ K & 0 & 0 & 0 & 0 & 0 & 0 & Kp & Ku & Kq & Kv \end{bmatrix}$$

The measurement equations are then given by

$$y = X \begin{pmatrix} \theta \\ \Omega \end{pmatrix} + \epsilon
 \tag{5-8}$$

The least squares estimation takes the form

$$E(y) = X \begin{pmatrix} \theta \\ \Omega \end{pmatrix} \text{ where} \quad (5-9)$$

$$\text{Var}(y) = \sigma^2 I .$$

The normal equations are given by

$$X'X \begin{pmatrix} \theta \\ \Omega \end{pmatrix} = X'y \quad (5-10)$$

and the estimates are given by

$$\begin{pmatrix} \hat{\theta} \\ \hat{\Omega} \end{pmatrix} = (X'X)^{-1} X'y = \begin{pmatrix} V & U \\ U' & W \end{pmatrix} X'y \quad (5-11)$$

where V is nxn, U is nx(4m-2), and W is (4m-2)x(4m-2). The predicted values of the observations are given by

$$\hat{y} = X \begin{pmatrix} \hat{\theta} \\ \hat{\Omega} \end{pmatrix} \quad (5-12)$$

and the deviations by

$$d = y - \hat{y} . \quad (5-13)$$

The estimate of σ is given by

$$s = \sqrt{d'd / (2nm - n - 4m + 2)} . \quad (5-14)$$

(At this point the above parameters are expressed in micrometer units.)

In summary, the results of this fitting procedure which are of primary interest are the set of n estimated fringe positions, $\hat{\theta}_i$, and the estimated standard deviation of a single measurement, s.

5.6. Computation of Test Flat Profile

Each estimated fringe profile is now converted to an estimate of the air space between the flats along the given diameter. Figure 5.5 shows a cross section of the setup which is cut perpendicular to the x axis at the position x_i . The separation d_i at the position x_i is related to the fringe profile θ_i by

$$d_i = d_0 - \frac{\lambda \hat{\theta}_i}{2r} \quad (5-15)$$

where d_0 is the separation of the flats along the primary fringe, and λ is the wavelength of the monochromatic light. (The d_i values are now expressed in microinches.) The separation d_i is also related to the profiles of the two flats. Figure 5.7 shows a cross-section of the setup along the test diameter as viewed horizontally with the upper flat being designated U and the lower flat L. For the purposes here it does not matter which is the test flat and which is the master. Let r^U and r^L be parallel auxiliary lines separated by an arbitrary distance h which pass through the upper and lower flats respectively, and for each line let the direction toward the other line be the positive direction. The adjacent profiles of the upper and lower flats can then be taken as deviations a_i^U and a_i^L from the lines r^U and r^L respectively. At every position x_i the relation between the parameters takes the form

$$h = a_i^U + a_i^L + d_i. \quad (5-16)$$

Substitution of the expression for d_i in equation 5-15 into equation 5-16 gives the following expression for the sum of the apparent profiles of the two flats:

$$a_i^U + a_i^L = \frac{\lambda \hat{\theta}_i}{2r} + h - d_0. \quad (5-17)$$

The value of h was arbitrary so it may be set equal to d_0 . Then

$$a_i^U + a_i^L = \frac{\lambda \hat{\theta}_i}{2r}. \quad (5-18)$$

Let the vector of profile values $a_i^U + a_i^L$ be denoted by a_I for the first run and a_{II} for the second run. Intuitively, the difference $a_I - a_{II}$ should be linear in x because the flats are rigid bodies. A statistical test is performed under this assumption in order to determine if there is a significant between-run error term. If such a term is found to be significant then the measurement process is said to be "not in control" and the measurements are repeated.

The test is implemented as follows. Let s_I and s_{II} be the respective standard deviations of a single measurement of runs 1 and 2, given in eq-

